


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551720	<b>Applicant(s)/Patent Under Reexamination</b>  JEON ET AL.
	<b>Examiner</b>  SHIN-HON CHEN	<b>Art Unit</b>  2431

SEARCHED			
Class	Subclass	Date	Examiner
713	155, 156, 184, 185	9/22/08	S.C.
705	67	9/22/08	S.C.
726	9	9/22/08	S.C.

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	9/22/08	S.C.
NPL search (google)	9/22/08	S.C.
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - updated search)	2/13/09	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
713	156-158,168,171,173,175	2/13/09	S.C.
726	4, 27	2/13/09	S.C.
705	67	2/13/09	S.C.

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